

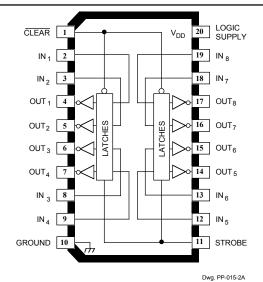
8-Bit Latched, DMOS Power Driver

Discontinued Product
These parts are no longer in production The device should not be purchased for new design applications. Samples are no longer avai
Date of status change: October 29, 2007
Recommended Substitutions:
We recommend the <u>A6B595</u> or <u>A6801</u> .

Allegro MicroSystems, Inc. reserves the right to make, from time to time, revisions to the anticipated product life cycle plan for a product to accommodate changes in production capabilities, alternative product availabilities, or market demand. The information included herein is believed to be accurate and reliable. However, Allegro MicroSystems, Inc. assumes no responsibility for its use; nor for any infringements of patents or other rights of third parties which may result from its use.

6**B**273

8-BIT LATCHED DMOS POWER DRIVER



Note that the A6B273KA (DIP) and the A6B273KLW (SOIC) are electrically identical and share a common terminal number assignment.

ABSOLUTE MAXIMUM RATINGS at $T_A = 25^{\circ}C$

Output Voltage, V_0 50 V
Output Drain Current,
Continuous, I _O 150 mA*
Peak, I _{OM} 500 mA†
Single-Pulse Avalanche Energy,
E _{AS}
Logic Supply Voltage, V _{DD} 7.0 V
Input Voltage Range,
V ₁ 0.3 V to +7.0 V
Package Power Dissipation,
P _D See Graph
Operating Temperature Range,
T _A 40°C to +125°C
Storage Temperature Range,
T _S 55°C to +150°C
* Each output, all outputs on.
† Pulse duration $\leq 100 \ \mu$ s, duty cycle $\leq 2\%$.
Caution: These CMOS devices have input static

Caution: These CMOS devices have input static protection (Class 3) but are still susceptible to damage if exposed to extremely high static electrical charges. The A6B273KA and A6B273KLW combine eight (positive-edgetriggered D-type) data latches and DMOS outputs for systems requiring relatively high load power. Driver applications include relays, solenoids, and other medium-current or high-voltage peripheral power loads. The CMOS inputs and latches allow direct interfacing with microprocessor-based systems. Use with TTL may require appropriate pull-up resistors to ensure an input logic high.

The DMOS output inverts the DATA input. All of the output drivers are disabled (the DMOS sink drivers turned OFF) with the CLEAR input low. The A6B273KA/KLW DMOS open-drain outputs are capable of sinking up to 500 mA. Similar devices with reduced $r_{DS(on)}$ are available as the A6273KA/KLW.

The A6B273KA is furnished in a 20-pin dual in-line plastic package. The A6B273KLW is furnished in a 20-lead wide-body, small-outline plastic package (SOIC) with gull-wing leads for surface-mount applications. Copper lead frames, reduced supply current requirements, and low on-state resistance allow both devices to sink 150 mA from all outputs continuously, to ambient temperatures over 85°C.

FEATURES

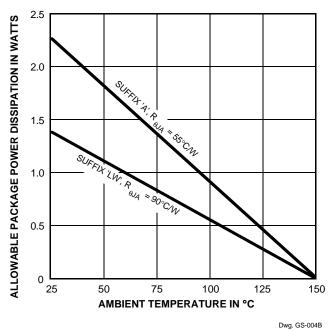
- 50 V Minimum Output Clamp Voltage
- 150 mA Output Current (all outputs simultaneously)
- **5** Ω Typical $r_{DS(on)}$
- Low Power Consumption
- Replacements for TPIC6B273N and TPIC6B273DW

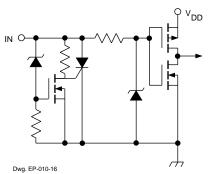
Selection Guide

Part Number	Pb-free*	Package	Packing	R _{θJA} (°C/W)	R _{θJC} (°C/W)
A6B273KLW-T	Yes	20-pin SOICW	37 per tube	70	17
A6B273KLWTR-T	Yes	20-pin SOICW	1000 per reel	70	17

*Pb-based variants are being phased out of the product line. Some variants cited in this footnote are in production but have been determined to be LAST TIME BUY or NOT FOR NEW DESIGN. This classification indicates that sale of this device is currently restricted to existing customer applications. The variants should not be purchased for new design applications because obsolescence in the near future is probable. Samples are no longer available. Status change for LAST TIME BUY: October 31, 2006. Deadline for receipt of LAST TIME BUY orders: April 27, 2007. These variants include: A6B273KLW and A6B273KLWTR. Status change for NOT FOR NEW DESIGN: May 1, 2006. These variants include: A6B273KA.

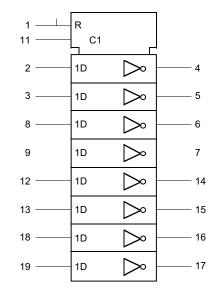




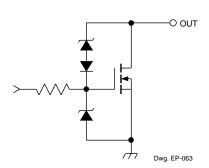


LOGIC INPUTS

LOGIC SYMBOL



Dwg. FP-046-1A



DMOS POWER DRIVER OUTPUT

CLEAR	Inputs STROBE	IN _x	OUT _x
L	Х	Х	Н
н	Г	Н	L
н		L	Н
н	L	Х	R

FUNCTION TABLE

L = Low Logic Level

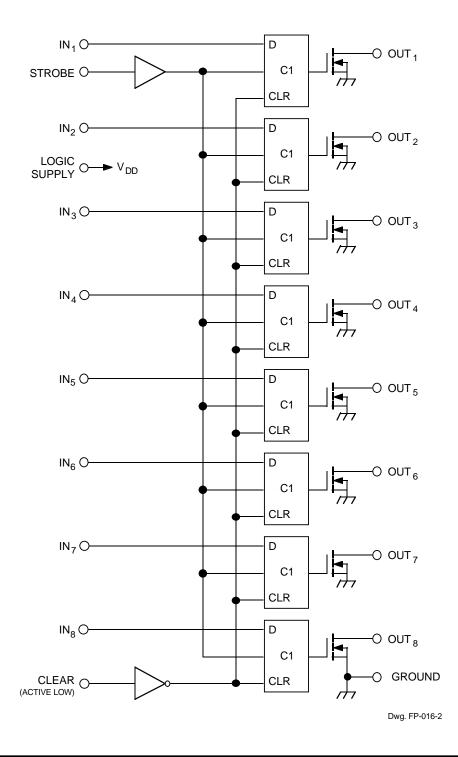
H = High Logic Level

X = Irrelevant

R = Previous State



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FUNCTIONAL BLOCK DIAGRAM

RECOMMENDED OPERATING CONDITIONS

over operating temperature range

Logic Supply Voltage Range, V _{DD}	4.5 V to 5.5 V
High-Level Input Voltage, VIH	$\dots \geq 0.85V_{DD}$
Low-level input voltage, V _{IL}	≤0.15V _{DD}

ELECTRICAL CHARACTERISTICS at T_A = +25°C, V_{DD} = 5 V, t_{ir} = t_{if} \leq 10 ns (unless otherwise specified).

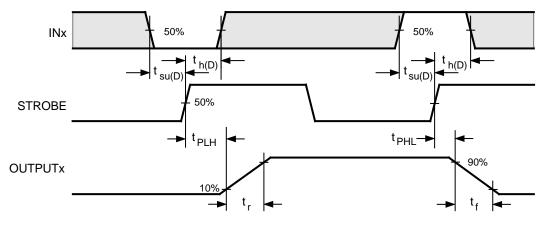
			Limits			
Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Logic Supply Voltage	V _{DD}	Operating	4.5	5.0	5.5	V
Output Breakdown Voltage	V _{(BR)DSX}	I _O = 1 mA	50			V
Off-State Output	I _{DSX}	V _O = 40 V, V _{DD} = 5.5 V		0.1	5.0	μΑ
Current		$V_{O} = 40 \text{ V}, V_{DD} = 5.5 \text{ V}, T_{A} = 125^{\circ}\text{C}$		0.15	8.0	μΑ
Static Drain-Source	r _{DS(on)}	I _O = 100 mA, V _{DD} = 4.5 V		4.2	5.7	Ω
On-State Resistance		I_{O} = 100 mA, V_{DD} = 4.5 V, T_{A} = 125°C		6.8	9.5	Ω
		I_{O} = 350 mA, V_{DD} = 4.5 V (see note)	_	5.5	8.0	Ω
Nominal Output Current	I _{ON}	V _{DS(on)} = 0.5 V, T _A = 85°C		90		mA
Logic Input Current	I _{IH}	V _I = V _{DD} = 5.5 V	_	_	1.0	μA
	IIL	V _I = 0, V _{DD} = 5.5 V	_	—	-1.0	μΑ
Prop. Delay Time	t _{PLH}	I _O = 100 mA, C _L = 30 pF	_	150	_	ns
	t _{PHL}	I _O = 100 mA, C _L = 30 pF		90	_	ns
Output Rise Time	t _r	I _O = 100 mA, C _L = 30 pF	_	200	_	ns
Output Fall Time	t _f	I _O = 100 mA, C _L = 30 pF	_	200	_	ns
Supply Current	I _{DD(OFF)}	V_{DD} = 5.5 V, Outputs off	_	20	100	μΑ
	I _{DD(ON)}	V_{DD} = 5.5 V, Outputs on		150	300	μΑ

Typical Data is at $V_{DD} = 5$ V and is for design information only.

NOTE — Pulse test, duration $\leq 100 \ \mu s$, duty cycle $\leq 2\%$.

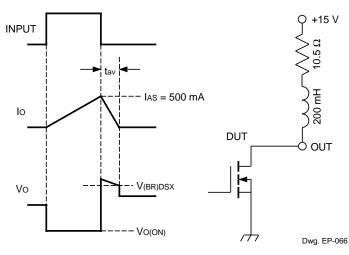


TIMING REQUIREMENTS



Dwg. WP-036-1

Input Active Time Before Strobe	
(Data Set-Up Time), t _{su(D)}	20 ns
Input Active Time After Strobe	
(Data Hold Time), t _{h(D)}	20 ns
Input Pulse Width, t _{w(D)}	40 ns
Input Logic High, V _{IH}	≥ 0.85 V _{CC}
Input Logic Low, V _{IL}	≤0.15V _{CC}



TEST CIRCUITS

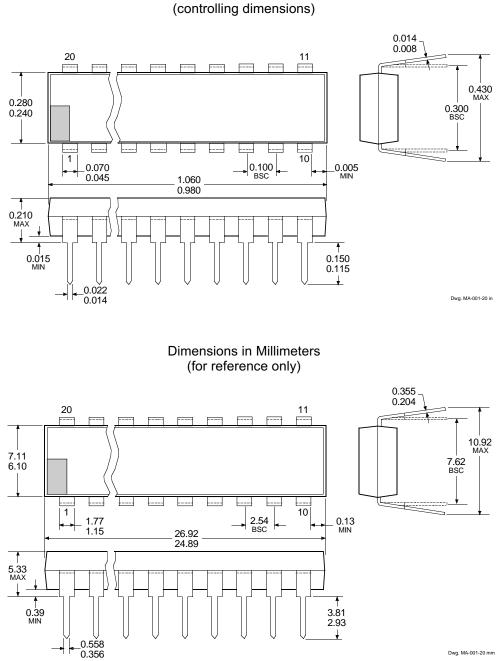
Single-Pulse Avalanche Energy Test Circuit and Waveforms

 $E_{AS} = I_{AS} \times V_{(BR)DSX} \times t_{AV}/2$

Terminal No.	Terminal Name	Function	
1	CLEAR	When (active) LOW, all latches are reset and all outputs go HIGH (turn OFF).	
2	IN_1	CMOS data input to a latch. When strobed, the output then inverts the data input (IN ₁ = HIGH, OUT ₁ = LOW).	
3	IN ₂	CMOS data input to a latch. When strobed, the output then inverts the data input ($IN_2 = HIGH$, $OUT_2 = LOW$).	
4	OUT ₁	Current-sinking, open-drain DMOS output.	
5	OUT ₂	Current-sinking, open-drain DMOS output.	
6	OUT ₃	Current-sinking, open-drain DMOS output.	
7	OUT_4	Current-sinking, open-drain DMOS output.	
8	IN ₃	CMOS data input to a latch. When strobed, the output then inverts the data input (IN ₃ = HIGH, $OUT_3 = LOW$).	
9	IN ₄	CMOS data input to a latch. When strobed, the output then inverts the data input (IN ₄ = HIGH, OUT ₄ = LOW).	
10	GROUND	Reference terminal for all voltage measurements.	
11	STROBE	A CMOS dynamic input to all latches. Data on each IN_x terminal is loaded into its associated latch on a low-to-high STROBE transition.	
12	IN ₅	CMOS data input to a latch. When strobed, the output then inverts the data input ($IN_5 = HIGH$, $OUT_5 = LOW$).	
13	IN ₆	CMOS data input to a latch. When strobed, the output then inverts the data input (IN ₆ = HIGH, OUT ₆ = LOW).	
14	OUT ₅	Current-sinking, open-drain DMOS output.	
15	OUT ₆	Current-sinking, open-drain DMOS output.	
16	OUT ₇	Current-sinking, open-drain DMOS output.	
17	OUT ₈	Current-sinking, open-drain DMOS output.	
18	IN ₇	CMOS data input to a latch. When strobed, the output then inverts the data input ($IN_7 = HIGH$, $OUT_7 = LOW$).	
19	IN ₈	CMOS data input to a latch. When strobed, the output then inverts the data input (IN ₈ = HIGH, OUT ₈ = LOW).	
20	LOGIC SUPPLY	(V _{DD}) The logic supply voltage (typically 5 V).	



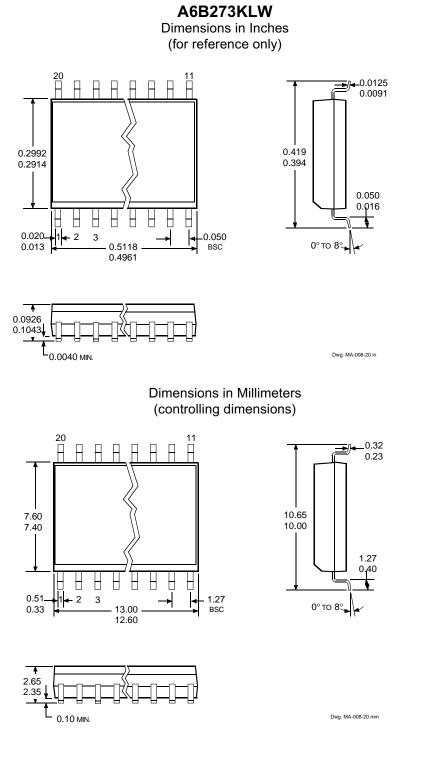
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A6B273KA Dimensions in Inches

NOTES: 1. Exact body and lead configuration at vendor's option within limits shown.

- 2. Lead spacing tolerance is non-cumulative.
- 3. Lead thickness is measured at seating plane or below.
- 4. Supplied in standard sticks/tubes of 18 devices.



NOTES: 1. Exact body and lead configuration at vendor's option within limits shown.

- 2. Lead spacing tolerance is non-cumulative.
 - 3. Supplied in standard sticks/tubes of 37 devices or add 'TR' to part number for tape and reel.



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Allegro products are not authorized for use as critical components in life-support devices or systems without express written approval.

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POWER INTERFACE DRIVERS

Function	Output Ratings*		Part Number [†]
SERIAL-I	NPUT LATCHED D	RIVERS	
8-Bit (saturated drivers)	-120 mA	50 V‡	5895
8-Bit	350 mA	50 V	5821
8-Bit	350 mA	80 V	5822
8-Bit	350 mA	50 V‡	5841
8-Bit	350 mA	80 V‡	5842
8-Bit (constant-current LED driver)	75 mA	17 V	6275
8-Bit (constant-current LED driver)	120 mA	24 V	6277
8-Bit (DMOS drivers)	250 mA	50 V	6595
8-Bit (DMOS drivers)	350 mA	50 V‡	6A595
8-Bit (DMOS drivers)	100 mA	50 V	6B595
10-Bit (active pull-downs)	-25 mA	60 V	5810-F and 6810
12-Bit (active pull-downs)	-25 mA	60 V	5811
16-Bit (constant-current LED driver)	75 mA	17 V	6276
20-Bit (active pull-downs)	-25 mA	60 V	5812-F and 6812
32-Bit (active pull-downs)	-25 mA	60 V	5818-F and 6818
32-Bit	100 mA	30 V	5833
32-Bit (saturated drivers)	100 mA	40 V	5832
PARALLEL	-INPUT LATCHED	DRIVERS	
4-Bit	350 mA	50 V‡	5800
8-Bit	-25 mA	60 V	5815
8-Bit	350 mA	50 V‡	5801
8-Bit (DMOS drivers)	100 mA	50 V	6B273
8-Bit (DMOS drivers)	250 mA	50 V	6273
SPECI	AL-PURPOSE DEV	ICES	
Unipolar Stepper Motor Translator/Driver	1.25 A	50 V‡	5804
Addressable 8-Bit Decoder/DMOS Driver	250 mA	50 V	6259
Addressable 8-Bit Decoder/DMOS Driver	350 mA	50 V‡	6A259
Addressable 8-Bit Decoder/DMOS Driver	100 mA	50 V	6B259
Addressable 28-Line Decoder/Driver	450 mA	30 V	6817

* Current is maximum specified test condition, voltage is maximum rating. See specification for sustaining voltage limits. Negative current is defined as coming out of (sourcing) the output.

† Complete part number includes additional characters to indicate operating temperature range and package style.

‡ Internal transient-suppression diodes included for inductive-load protection.



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